ZX3CD3S1M832

MPPS™ Miniature Package Power Solutions 40V PNP LOW SATURATION TRANSISTOR AND 40V, 1A SCHOTTKY DIODE COMBINATION DUAL

SUMMARY

PNP Transistor — V_{CEO} =-40V; R_{SAT} = 104m Ω ; I_C = -3A

Schottky Diode — $V_R = 40V$; $V_F = 500mV$ (@1A); $I_C=1A$

DESCRIPTION

Packaged in the new innovative 3mm x 2mm MLP this combination dual comprises an ultra low saturation PNP transistor and a 1A Schottky barrier diode. This excellent combination provides users with highly efficient performance in applications including DC-DC and charging circuits.

Users will also gain several other key benefits:

Performance capability equivalent to much larger packages

- Improved circuit efficiency & power levels
- PCB area and device placement savings

Lower package height (0.9mm nom)

Reduced component count

FEATURES

- Extremely Low Saturation Voltage (-220mV @-1A)
- H_{FF} characterised up to -3A
- I_C = -3A Continuous Collector Current
- Extremely Low V_F, fast switching Schottky
- 3mm x 2mm MLP

APPLICATIONS

- DC DC Converters
- Mobile Phones
- Charging Circuits
- Motor control

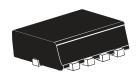
ORDERING INFORMATION

DEVICE	REEL	TAPE WIDTH	QUANTITY PER REEL
ZX3CD3S1M832TA	7''	8mm	3000
ZX3CD3S1M832TC	13′′	8mm	10000

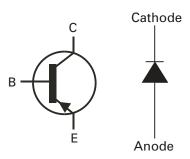
DEVICE MARKING

3S1

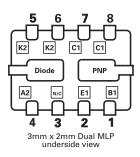
ISSUE 3 - OCTOBER 2007



3mm x 2mm Dual Die MLP



PINOUT





ZX3CD3S1M832

ABSOLUTE MAXIMUM RATINGS.

PARAMETER	SYMBOL	VALUE	UNIT
Transistor			
Collector-Base Voltage	V _{CBO}	-50	V
Collector-Emitter Voltage	V _{CEO}	-40	V
Emitter-Base Voltage	V _{EBO}	-7.5	V
Peak Pulse Current	I _{CM}	-4	А
Continuous Collector Current (a)(f)	Ι _C	-3	А
Base Current	IB	1000	mA
Power Dissipation at TA=25°C (a)(f) Linear Derating Factor	P _D	1.5 12	W mW/°C
Power Dissipation at TA=25°C (b)(f) Linear Derating Factor	P _D	2.45 19.6	W mW/°C
Power Dissipation at TA=25°C (c)(f) Linear Derating Factor	P _D	1 8	W mW/°C
Power Dissipation at TA=25°C (d)(f) Linear Derating Factor	P _D	1.13 9	W mW/°C
Power Dissipation at TA=25°C (d)(g) Linear Derating Factor	P _D	1.7 13.6	W mW/°C
Power Dissipation at TA=25°C (e)(g) Linear Derating Factor	P _D	3 24	W mW/°C
Storage Temperature Range	T _{stg}	-55 to +150	°C
Junction Temperature	Ti	150	°C

THERMAL RESISTANCE

PARAMETER	SYMBOL	VALUE	UNIT
Junction to Ambient (a)(f)	R _{θJA}	83	°C/W
Junction to Ambient (b)(f)	R _{θJA}	51	°C/W
Junction to Ambient (c)(f)	R _{θJA}	125	°C/W
Junction to Ambient (d)(f)	R _{θJA}	111	°C/W
Junction to Ambient (d)(g)	R _{θJA}	73.5	°C/W
Junction to Ambient (e)(g)	R _{θJA}	41.7	°C/W

Notes

(a) For a dual device surface mounted on 8 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with all exposed pads attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.

(b) Measured at t<5 secs for a dual device surface mounted on 8 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with all exposed pads attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.
 (c) For a dual device surface mounted on 8 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with minimal lead connections only.
 (d) For a dual device surface mounted on 10 sq cm single sided 1oz copper on FR4 PCB, in still air conditions with all exposed pads attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.

(e) For a dual device surface mounted on 85 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with all exposed pads attached attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device. (f) For a dual device with one active die.

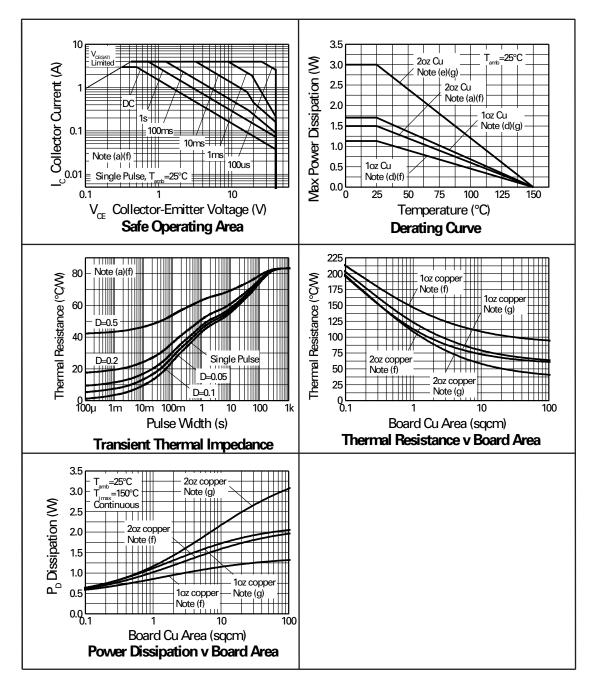
(g) For dual device with 2 active die running at equal power.

(h) Repetitive rating - pulse width limited by max junction temperature. Refer to Transient Thermal Impedance graph.

(i) The minimum copper dimensions required for mounting are no smaller than the exposed metal pads on the base of the device as shown in the package dimensions data. The thermal resistance for a dual device mounted on 1.5mm thick FR4 board using minimum copper 1 oz weight, 1mm wide tracks and one half of the device active is Rth = 250°C/W giving a power rating of Ptot = 500mW.



ZX3CD3S1M832



TRANSISTOR TYPICAL CHARACTERISTICS



ZX3CD3S1M832

ABSOLUTE MAXIMUM RATINGS.

PARAMETER	SYMBOL	VALUE	UNIT
Schottky Diode			
Continuous Reverse Voltage	V _R	40	V
Forward Voltage @ I _F =1000mA(typ)	V _F	425	mV
Forward Current	I _F	1850	mA
Average Peak Forward Current D=50%	I _{FAV}	3	А
Non Repetitive Forward Current ts 100 μs ts 10 ms	I _{FSM}	12 7	A A
Power Dissipation at TA=25°C (a)(f) Linear Derating Factor	P _D	1.2 12	W mW/°C
Power Dissipation at TA=25°C (b)(f) Linear Derating Factor	P _D	2 20	W mW/°C
Power Dissipation at TA=25°C (c)(f) Linear Derating Factor	P _D	0.8 8	W mW/°C
Power Dissipation at TA=25°C (d)(f) Linear Derating Factor	P _D	0.9 9	W mW/°C
Power Dissipation at TA=25°C (d)(g) Linear Derating Factor	P _D	1.36 13.6	W mW/°C
Power Dissipation at TA=25°C (e)(g) Linear Derating Factor	P _D	2.4 24	W mW/°C
Storage Temperature Range	T _{stg}	-55 to +150	°C
Junction Temperature	Ti	125	°C

THERMAL RESISTANCE

PARAMETER	SYMBOL	VALUE	UNIT
Junction to Ambient (a)(f)	R _{θJA}	83	°C/W
Junction to Ambient (b)(f)	R _{θJA}	51	°C/W
Junction to Ambient (c)(f)	R _{θJA}	125	°C/W
Junction to Ambient (d)(f)	R _{θJA}	111	°C/W
Junction to Ambient (d)(g)	R _{θJA}	73.5	°C/W
Junction to Ambient (e)(g)	R _{θJA}	41.7	°C/W

Notes

(a) For a dual device surface mounted on 8 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with all exposed pads attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.

(b) Measured at t<5 secs for a dual device surface mounted on 8 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with all exposed pads attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.
 (c) For a dual device surface mounted on 8 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with minimal lead connections only.

(d) For a dual device surface mounted on 10 sq cm single sided 1oz copper on FR4 PCB, in still air conditions with all exposed pads attached attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.

(e) For a dual device surface mounted on 85 sq cm single sided 2oz copper on FR4 PCB, in still air conditions with all exposed pads attached attached. The copper area is split down the centre line into two separate areas with one half connected to each half of the dual device.
 (f) For a dual device with one active die.

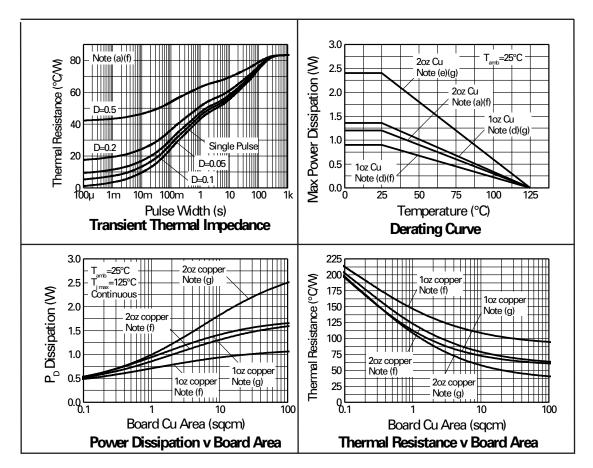
(g) For dual device with 2 active die running at equal power.

(h) Repetitive rating - pulse width limited by max junction temperature. Refer to Transient Thermal Impedance graph.

(i) The minimum copper dimensions required for mounting are no smaller than the exposed metal pads on the base of the device as shown in the package dimensions data. The thermal resistance for a dual device mounted on 1.5mm thick FR4 board using minimum copper 1 oz weight, 1mm wide tracks and one half of the device active is Rth = 250°C/W giving a power rating of Ptot = 400mW.



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SCHOTTKY TYPICAL CHARACTERISTICS

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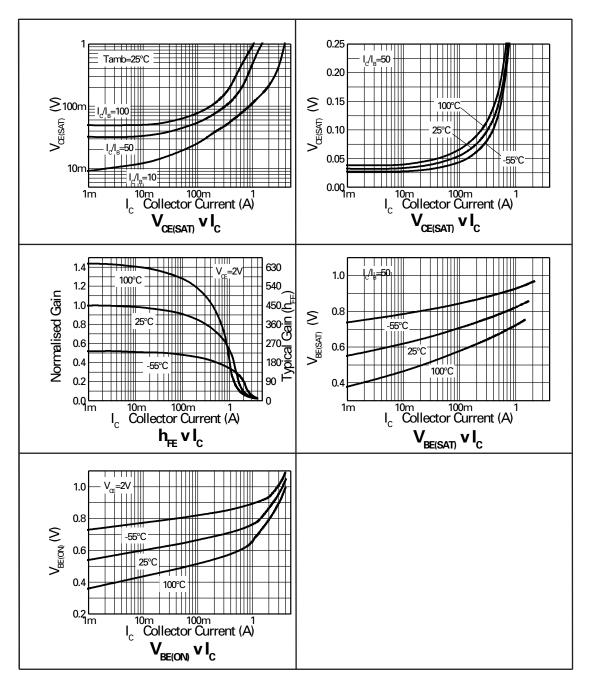
ELECTRICAL CHARACTERISTICS (at T_{amb} = 25°C unless otherwise stated).

PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	CONDITIONS.
TRANSISTOR ELECTRICAL CHARA	CTERISTICS					
Collector-Base Breakdown Voltage	V _{(BR)CBO}	-50	-80		V	I _C =-100μA
Collector-Emitter Breakdown Voltage	V _{(BR)CEO}	-40	-70		V	I _C =-10mA*
Emitter-Base Breakdown Voltage	V _{(BR)EBO}	-7.5	-8.5		V	I _E =-100μA
Collector Cut-Off Current	I _{CBO}			-25	nA	V _{CB} =-40V
Emitter Cut-Off Current	I _{EBO}			-25	nA	V _{EB} =-6V
Collector Emitter Cut-Off Current	I _{CES}			-25	nA	V _{CES} =-32V
Collector-Emitter Saturation Voltage	V _{CE(sat)}		-25 -150 -195 -210 -260	-40 -220 -300 -300 -370	mV mV mV mV mV	$ \begin{array}{c} I_{C}{=}{-}0.1A, \ I_{B}{=}{-}10mA^{*} \\ I_{C}{=}{-}1A, \ I_{B}{=}{-}50mA^{*} \\ I_{C}{=}{-}1.5A, \ I_{B}{=}{-}100mA^{*} \\ I_{C}{=}{-}2A, \ I_{B}{=}{-}200mA^{*} \\ I_{C}{=}{-}2.5A, \ I_{B}{=}{-}250mA^{*} \end{array} $
Base-Emitter Saturation Voltage	V _{BE(sat)}		-0.97	-1.05	V	I _C =-2.5A, I _B =-250mA*
Base-Emitter Turn-On Voltage	V _{BE(on)}		-0.89	-0.95	V	I _C =-2.5A, V _{CE} =-2V*
Static Forward Current Transfer Ratio	h _{FE}	300 300 180 60 12	480 450 290 130 22			$ \begin{array}{c} I_{C} = -10 \text{mA}, \ V_{CE} = -2 \text{V}^{*} \\ I_{C} = -0.1 \text{A}, \ V_{CE} = -2 \text{V}^{*} \\ I_{C} = -1 \text{A}, \ V_{CE} = -2 \text{V}^{*} \\ I_{C} = -1.5 \text{A}, \ V_{CE} = -2 \text{V}^{*} \\ I_{C} = -3 \text{A}, \ V_{CE} = -2 \text{V}^{*} \end{array} $
Transition Frequency	f _T	150	190		MHz	I _C =-50mA, V _{CE} =-10V f=100MHz
Output Capacitance	C _{obo}		19	25	pF	V _{CB} =-10V, f=1MHz
Turn-On Time	t _(on)		40		ns	V _{CC} =-15V, I _C =-0.75A
Turn-Off Time	t _(off)		435		ns	I _{B1} =I _{B2} =-15mA
SCHOTTKY DIODE ELECTRICAL CH	ARACTERIS	TICS				
Reverse Breakdown Voltage	V _{(BR)R}	40	60		V	I _R =300μA
Forward Voltage	V _F		240 265 305 355 390 425 495 420	270 290 340 400 450 500 600 	mV mV mV mV mV mV	$I_{F}=50mA^{*}$ $I_{F}=100mA^{*}$ $I_{F}=250mA^{*}$ $I_{F}=500mA^{*}$ $I_{F}=750mA^{*}$ $I_{F}=1000mA^{*}$ $I_{F}=1500mA^{*}$ $I_{F}=1000mA, T_{a}=100^{\circ}C^{*}$
Reverse Current	I _R		50	100	μA	V _R =30V
Diode Capacitance	CD		25		pF	f=1MHz,V _R =25V
Reverse Recovery Time	t _{rr}		12		ns	switched from $I_F = 500$ mA to $I_R = 500$ m Measured at $I_R = 50$ mA

*Measured under pulsed conditions.



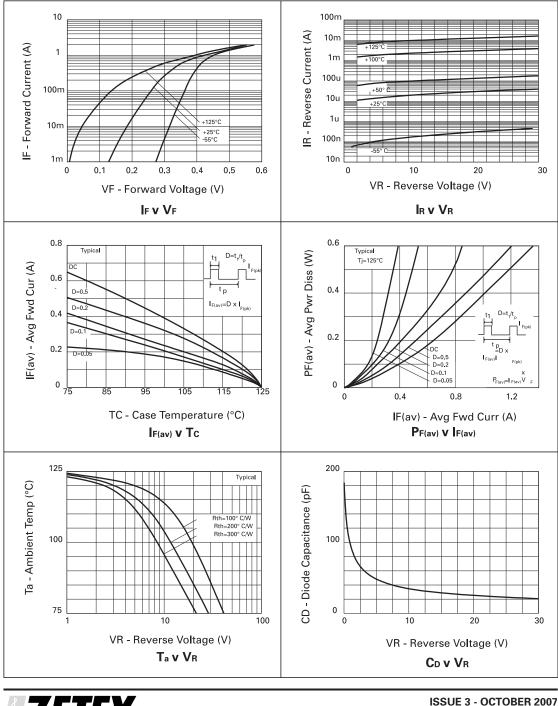
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TRANSISTOR TYPICAL CHARACTERISTICS



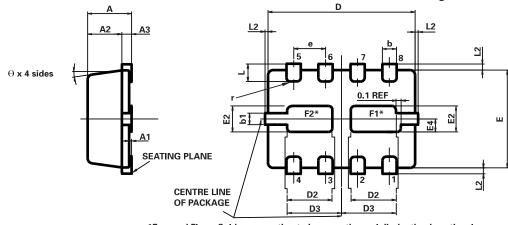
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SCHOTTKY TYPICAL CHARACTERISTICS



ZX3CD3S1M832



MLP832 PACKAGE OUTLINE (3mm x 2mm Micro Leaded Package)

*Exposed Flags. Solder connection to improve thermal dissipation is optional. F1 at collector 1 potential

F2 at collector 2 potential

CONTROLLING DIMENSIONS IN MILLIMETRES APPROX. CONVERTED DIMENSIONS IN INCHES

MLP832 PACKAGE DIMENSIONS

	MILLIN	IETRES	INC	HES		MILLIMETRES		INCHES	
DIM	MIN.	MAX.	MIN.	MAX.	DIM	MIN.	MAX.	MIN.	MAX.
А	0.80	1.00	0.031	0.039	е	0.65	REF	0.025	6 BSC
A1	0.00	0.05	0.00	0.002	E	2.00	BSC	0.0787	BSC
A2	0.65	0.75	0.0255	0.0295	E2	0.43	0.63	0.017	0.0249
A3	0.15	0.25	0.006	0.0098	E4	0.16	0.36	0.006	0.014
b	0.24	0.34	0.009	0.013	L	0.20	0.45	0.0078	0.0157
b1	0.17	0.30	0.0066	0.0118	L2		0.125	0.00	0.005
D	3.00	BSC	0.118	BSC	r	r 0.075 BSC		0.0029 BSC	
D2	0.82	1.02	0.032	0.040	θ	0°	12°	0°	12°
D3	1.01	1.21	0.0397	0.0476					

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